Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/722,033	SATORU MIYANO	
Examiner	Art Unit	
Pablo Whaley	1631	

	SEAR	SEARCHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: UPDATED	3/13/2007	PW		
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